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Pending Claims (the claims have not been amended in this reply):

1.-4. (Canceled).

5. (Previously Presented) A semi-conductor component comprising:

a semiconductor body having a matrix formed from a first semi-conductor material having a first lattice constant, the matrix comprising a sequence of layers,

wherein each layer of the matrix comprises several sub-monolayer islands containing a second semi-conductor material having a second lattice constant different from the first lattice constant,

wherein the sub-monolayer islands are separated from the one another and embedded in the matrix formed from the first semi-conductor material, and

wherein the sub-monolayer islands within each layer are located in a common plane perpendicular to a growth direction for the sequence of layers.

- 6. (Previously Presented) The semi-conductor component of claim 5, wherein the second semi-conductor material is more highly dopable than the first semi-conductor material.
- 7. (Previously Presented) The semi-conductor component of claim 5, wherein the separation between consecutive layers of the sub-monolayer islands decreases toward a main surface of the semiconductor body.
- 8. (Previously Presented) The semi-conductor component of claim 5, further comprising a layer of the second semi-conductor material completely covering a main surface of the semiconductor body.

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9. (Previously Presented) The semi-conductor component of claim 5, wherein the first semi-conductor material comprises ZnSe and the second semi-conductor material comprises ZnTe.

- 10. (Previously Presented) The semi-conductor component of claim 8, wherein the layer completely covering the main surface has a thickness less than 10 nm.
- 11. (Previously Presented) The semi-conductor component of claim 5, wherein a main surface of the semiconductor body has a doping level greater than 10¹⁹cm⁻³.
- 12. (Previously Presented) The semi-conductor component of claim 7, wherein the main surface of the semiconductor body has a doping level greater than 10¹⁹cm⁻³.
- 13. (Previously Presented) The semi-conductor component of claim 6, wherein the separation between consecutive layers of the sub-monolayer islands decreases toward a main surface of the semiconductor body.
- 14. (Previously Presented) The semi-conductor component of claim 7, further comprising a layer of the second semi-conductor material completely covering the main surface of the semiconductor body.
- 15. (Previously Presented) The semi-conductor component of claim 13, further comprising a layer of the second semi-conductor material completely covering the main surface of the semiconductor body.
- 16. (Previously Presented) The semi-conductor component of claim 5, wherein the first semi-conductor material comprises ZnSe.

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17. (Previously Presented) The semi-conductor component of claim 5, wherein the second semi-conductor material comprises ZnTe.

18. (Previously Presented) A semi-conductor component comprising:

a matrix comprising a first semi-conductor material having a first lattice constant, the matrix having a sequence of layers,

wherein each layer of the matrix comprises several sub-monolayer islands containing a second semi-conductor material having a second lattice constant different from the first lattice constant,

wherein the sub-monolayer islands are separated from the one another and embedded in the matrix, and

wherein the sub-monolayer islands within each layer are located in a common plane perpendicular to a growth direction for the sequence of layers.

19. (Previously Presented) A semi-conductor component comprising:

a matrix comprising ZnSe and defining a sequence of layers, wherein each layer of the matrix comprises several sub-monolayer islands comprising ZnTe, the sub-monolayer islands being separated from the one another and embedded in the matrix; and a layer comprising ZnTe covering the surface of the matrix, and

wherein the sub-monolayer islands within each layer are located in a common plane perpendicular to a growth direction for the sequence of layers.